Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination			
	10050168	KONDOH ET AL.			
	Examiner:	Art Unit:			
	Lee, Jinhee J	2831			

						ISSUE	CLAS	SIFICA	TION				
	ORIGINAL						CROSS REFERENCE(S)						
CLASS 174 INT			SUBCLASS				SUBCLASS (ONE SUBCLASS PER BLOCK)						
174 72a		0	72R	95	69	71R	2						
	INT	ERNA	TIONAL	CLASSI	FICATION								
н	0	2	g	1	/ 00								
					1								
					1								
					1								
					1								
Jini	nee Lee (Assist		aminer)		2/4/05 (Date)	DE	AN A R	FICHARD	relations	Total Cla	aims Allowed	ı: 3	
			Examin		9/1/05 (Date)	OULTUNG	UNI PA	TENT EXA	WINEK	O.G. Pri	nt Claim(s)	O.G. Pr 1	

U.S. Patent and Trademark Office

Part of Paper No. 0205